TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

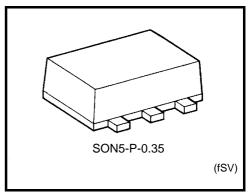
# TC7SH04FS

#### **INVERTER**

#### **Features**

High speed:  $t_{pd}=3.8$  ns (typ.) at  $V_{CC}=5$  V Low power dissipation:  $I_{CC}=2~\mu A$  (max) at  $T_{a}=25^{\circ}C$  High noise immunity:  $V_{NIH}=V_{NIL}=28\%~V_{CC}$  (min) 5.5V tolerant input.

Wide operating voltage range: V<sub>CC</sub> (opr) = 2~5.5 V

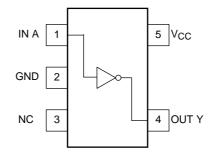


Weight: 0.001 g (Typ.)

#### Marking

# Type Name

#### Pin Assignment (top view)



# **Maximum Ratings (Ta = 25°C)**

Characteristics	Symbol	Rating	Unit
Supply voltage range	Vcc	-0.5~7.0	V
DC input voltage	V <sub>IN</sub>	-0.5~7.0	V
DC output voltage	V <sub>OUT</sub>	-0.5~V <sub>CC</sub> + 0.5	V
Input diode current	lıĸ	-20	mA
Output diode current	lok	±20	mA
DC output current	lout	±25	mA
DC V <sub>CC</sub> /ground current	Icc	±50	mA
Power dissipation	PD	50	mW
Storage temperature	T <sub>stg</sub>	-65~150	°C

# Logic Diagram



## **Truth Table**

А	Υ
L	Н
Н	L

# **Recommended Operating Conditions**

Characteristics	Symbol	Rating	Unit	
Supply voltage	V <sub>CC</sub>	2.0~5.5	V	
Input voltage	V <sub>IN</sub>	0~5.5	V	
Output voltage	V <sub>OUT</sub>	0~Vcc	V	
Operating temperature	T <sub>opr</sub>	-40~85	°C	
Input rise and fall time	dt/dv	0~100 (V <sub>CC</sub> = 3.3 ± 0.3 V)	ns/V	
input rise and fail time	αι/αν	$0 \sim 20 \; (V_{CC} = 5 \pm 0.5 \; V)$	113/ V	

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#### **Electrical Characteristics**

#### **DC Characteristics**

Characteristics   Symbol		Test	rcuit Test Condition VC			Ta = 25°C			Ta = -40~85°C		
		Circuit			V <sub>CC</sub> (V)	Min	Тур.	Max	Min	Max	Unit
High-level input					2.0	1.50	_	_	1.50	_	
voltage	V <sub>IH</sub>	_		_	3.0~ 5.5	V <sub>CC</sub> × 0.7	_	_	V <sub>CC</sub> × 0.7	_	V
Low-level input					2.0	_		0.50	_	0.50	V
voltage	V <sub>IL</sub>	_		_		_		V <sub>CC</sub> × 0.3	_	V <sub>CC</sub> × 0.3	
			V <sub>IN</sub> = V <sub>IL</sub>	Ι <sub>ΟΗ</sub> = -50 μΑ	2.0	1.9	2.0	_	1.9	_	V
					3.0	2.9	3.0	_	2.9	_	
High-level V <sub>OH</sub>	V <sub>OH</sub>	_			4.5	4.4	4.5	_	4.4	_	
				$I_{OH} = -4 \text{ mA}$	3.0	2.58		_	2.48	_	
				$I_{OH} = -8 \text{ mA}$	4.5	3.94		_	3.80	_	
				I <sub>OL</sub> = 50 μA	2.0	_	0.0	0.1	_	0.1	_
					3.0	_	0.0	0.1	_	0.1	
Low-level output voltage	_	V <sub>IN</sub> = V <sub>IH</sub>		4.5	_	0.0	0.1	_	0.1	V	
				I <sub>OL</sub> = 4 mA	3.0	_	_	0.36	_	0.44	
				I <sub>OL</sub> = 8 mA	4.5			0.36	_	0.44	
Input leakage current	I <sub>IN</sub>	_	V <sub>IN</sub> = 5.5 V or GND		0~ 5.5	_		±0.1		±1.0	μА
Quiescent supply current	Icc		V <sub>IN</sub> = V <sub>CC</sub> or GND			_	_	2.0	_	20.0	μА

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#### AC Characteristics (Input: $t_r = t_f = 3 \text{ ns}$ )

Characteristics Symbol	Cumbal	Test	7	Test Condition	n	Ta = 25°C			Ta = -40~85°C		Unit
	Circuit		V <sub>CC</sub> (V)	C <sub>L</sub> (pF)	Min	Тур.	Max	Min	Max	Unit	
Propagation delay tpLH time tpHL				3.3 ± 0.3	15	_	5.0	7.1	1.0	8.5	- ns
	•				50		7.5	10.6	1.0	12.0	
				5.0 ± 0.5	15	_	3.8	5.5	1.0	6.5	
			5.0 ± 0.5	50		5.3	7.5	1.0	8.5		
Input capacitance	C <sub>IN</sub>	_		_			4	10	_	10	pF
Power dissipation capacitance	$C_{PD}$	_			(Note)	_	13	_	_		pF

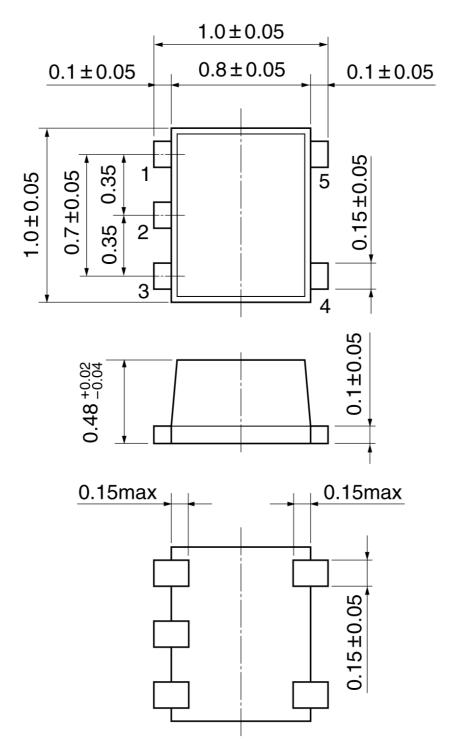
Note: C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

$$I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}$$

## **Package Dimensions**

SON5-P-0.35 Unit:mm



Weight: 0.001 g (typ.)

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